

ZXMN2B01F 20V SOT23 N-channel enhancement mode MOSFET with low gate drive capability

Summary

| V _{(BR)DSS} | R _{DS(on)} (Ω) | I _D (A) |
|----------------------|--------------------------------|--------------------|
| | 0.100 @ V _{GS} = 4.5V | 2.4 |
| 20 | 0.150 @ V _{GS} = 2.5V | 2.0 |
| | 0.200 @ V _{GS} = 1.8V | 1.7 |



This new generation trench MOSFET from Zetex features low onresistance achievable with low gate drive.

Features

- Low on-resistance
- · Fast switching speed
- · Low gate drive capability
- SOT23 package

Applications

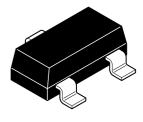
- DC-DC converters
- Power management functions
- Disconnect switches
- Motor control

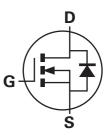
Ordering information

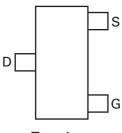
| Device | Reel size (inches) | Tape width (mm) | Quantity per reel |
|-------------|-----------------------|--------------------|-------------------|
| ZXMN2B01FTA | 7 | 8 | 3,000 |

Device marking

2B1









Absolute maximum ratings

| Parameter | Symbol | Limit | Unit | |
|---|---|----------------|-------|---|
| Drain-source voltage | V _{DSS} | 20 | V | |
| Gate-source voltage | V _{GS} | ±8 | V | |
| Continuous drain current | @ V_{GS} = 4.5V; T_{amb} =25°C ^(b) | Ι _D | 2.4 | А |
| | @ V_{GS} = 4.5V; T_{amb} =70°C ^(b) | | 1.9 | А |
| | @ V_{GS} = 4.5V; T_{amb} =25°C ^(a) | | 2.1 | А |
| Pulsed drain current ^(c) | I _{DM} | 11.8 | А | |
| Continuous source current | ۱ _S | 1.4 | А | |
| Pulsed source current (boo | I _{SM} | 11.8 | А | |
| Power dissipation at T _{amb} : | PD | 625 | mW | |
| Linear derating factor | | 5 | mW/°C | |
| Power dissipation at T _{amb} : | PD | 806 | mW | |
| Linear derating factor | | 6.4 | mW/°C | |
| Operating and storage tem | T _j , T _{stg} | -55 to +150 | °C | |

Thermal resistance

| Parameter | Symbol | Limit | Unit |
|------------------------------------|----------------|-------|------|
| Junction to ambient ^(a) | R_{\ThetaJA} | 200 | °C/W |
| Junction to ambient ^(b) | R_{\ThetaJA} | 155 | °C/W |

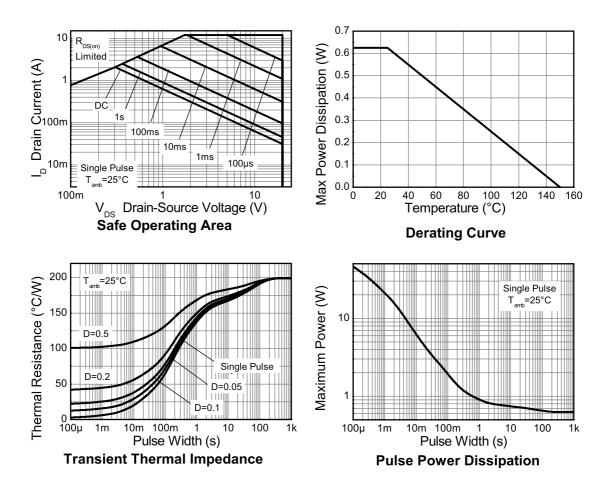
NOTES:

(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(b) For a device surface mounted on FR4 PCB measured at t ${\leq}5$ sec.

(c) Repetitive rating - 25mm x 25mm FR4 PCB, D=0.02, pulse width 300µs - pulse width limited by maximum junction temperature.

Thermal characteristics



| Parameter | Symbol | Min. | Тур. | Max. | Unit | Conditions |
|--|----------------------|------|------|-------|------|---|
| Static | | | | | | |
| Drain-source breakdown voltage | V _{(BR)DSS} | 20 | | | V | I _D = 250μA, V _{GS} =0V |
| Zero gate voltage drain current | I _{DSS} | | | 1 | μA | V _{DS} = 20V, V _{GS} =0V |
| Gate-body leakage | I _{GSS} | | | 100 | nA | $V_{GS}=\pm 8V, V_{DS}=0V$ |
| Gate-source threshold voltage | V _{GS(th)} | 0.4 | | 1.0 | V | $I_D = 250 \mu A$, $V_{DS} = V_{GS}$ |
| Static drain-source on-state | R _{DS(on)} | | | 0.100 | Ω | V_{GS} = 4.5V, I _D = 2.4A |
| resistance ^(*) | | | | 0.150 | Ω | V_{GS} = 2.5V, I _D = 2.0A |
| | | | | 0.200 | Ω | V _{GS} = 1.8V, I _D = 1.7A |
| Forward transconductance ^{(*)(‡)} | 9 _{fs} | | 6.1 | | S | V _{DS} = 10V, I _D = 2.4A |
| Dynamic ^(‡) | • | | | | | |
| Input capacitance | C _{iss} | | 370 | | pF | V _{DS} = 10V, V _{GS} =0V |
| Output capacitance | C _{oss} | | 81 | | pF | f=1MHz |
| Reverse transfer capacitance | C _{rss} | | 46 | | pF | |
| Switching ^(†) ^(‡) | | | • | | | |
| Turn-on-delay time | t _{d(on)} | | 2.2 | | ns | V _{DD} = 10V, V _{GS} = 4.5V |
| Rise time | t _r | | 3.6 | | ns | I _D = 1A |
| Turn-off delay time | t _{d(off)} | | 17.8 | | ns | $R_{G} \approx 6.0\Omega$ |
| Fall time | t _f | | 10.5 | | ns | |
| Total gate charge | Qg | | 4.8 | | nC | V _{DS} = 10V, V _{GS} = 4.5V |
| Gate-source charge | Q _{gs} | | 0.6 | | nC | I _D = 2.4A |
| Gate drain charge | 0 _{gd} | | 1.0 | | nC | |
| Source-drain diode | • | | | | | |
| Diode forward voltage ^(*) | V _{SD} | | 0.73 | 0.95 | V | T _j =25°C, I _S = 1.2A, V _{GS} =0V |
| Reverse recovery time ^(‡) | t _{rr} | | 6.7 | | ns | T _j =25°C, I _F = 1.1A, |
| Reverse recovery charge ^(‡) | 0 _{rr} | | 1.3 | | nC | di/dt=100A/ms |

Electrical characteristics (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

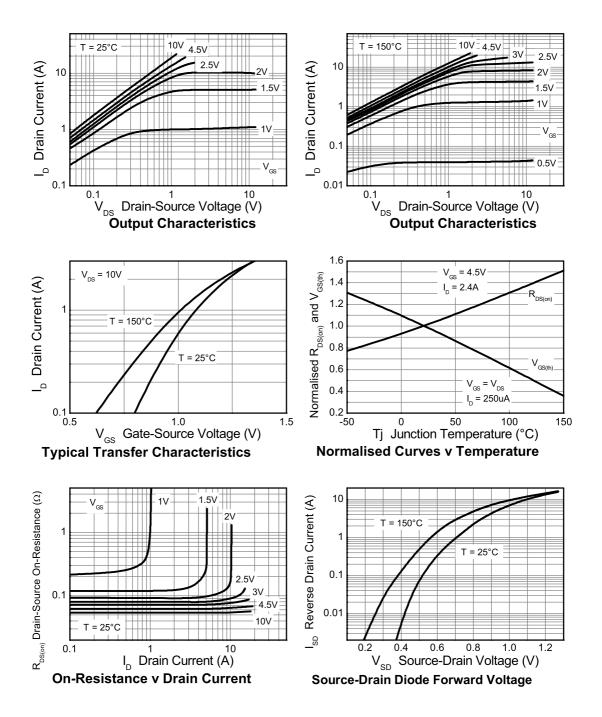
NOTES:

(*) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.

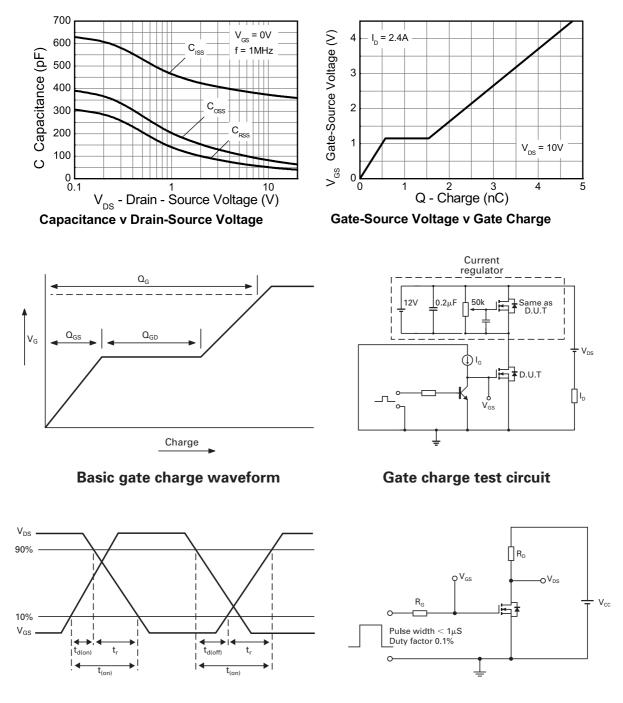
(†) Switching characteristics are independent of operating junction temperature.

(‡) For design aid only, not subject to production testing.

Typical characteristics



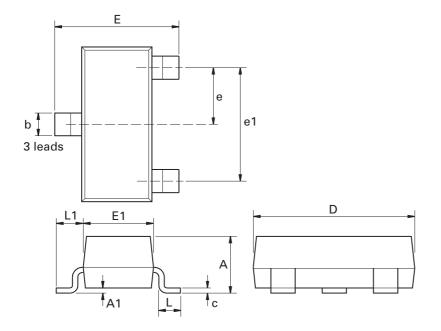
Typical characteristics



Switching time test circuit

Switching time waveforms

Package outline - SOT23



| Dim. | Millin | neters | Inc | hes | Dim. | Dim. Millim | | Inches | |
|------|--------|--------|--------|-------|------|-------------|------|--------|-------|
| | Min. | Max. | Min. | Max. | | Min. | Max. | Max. | Max. |
| А | - | 1.12 | - | 0.044 | e1 | 1.90 | NOM | 0.075 | NOM |
| A1 | 0.01 | 0.10 | 0.0004 | 0.004 | E | 2.10 | 2.64 | 0.083 | 0.104 |
| b | 0.30 | 0.50 | 0.012 | 0.020 | E1 | 1.20 | 1.40 | 0.047 | 0.055 |
| С | 0.085 | 0.120 | 0.003 | 0.008 | L | 0.25 | 0.62 | 0.018 | 0.024 |
| D | 2.80 | 3.04 | 0.110 | 0.120 | L1 | 0.45 | 0.62 | 0.018 | 0.024 |
| е | 0.95 | NOM | 0.0375 | NOM | - | - | - | - | - |

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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Zetex sales offices

| Europe | Americas | Asia Pacific | Corporate Headquarters |
|---|---|--|--|
| Zetex GmbH Kustermann-park Balanstraße 59 D-81541 München Germany | Zetex Inc 700 Veterans Memorial Highway Hauppauge, NY 11788 USA | Zetex (Asia Ltd) 3701-04 Metroplaza Tower 1 Hing Fong Road, Kwai Fong Hong Kong | Zetex Semiconductors plc Zetex Technology Park, Chadderton Oldham, OL9 9LL United Kingdom |
| Telefon: (49) 89 45 49 49 0 Fax: (49) 89 45 49 49 49 europe.sales@zetex.com | Telephone: (1) 631 360 2222 Fax: (1) 631 360 8222 usa.sales@zetex.com | Telephone: (852) 26100 611 Fax: (852) 24250 494 asia.sales@zetex.com | Telephone: (44) 161 622 4444 Fax: (44) 161 622 4446 hq@zetex.com |

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